Features

- No External Components Except PIN Diode
- Supply-voltage Range: 2.7V to 5.5V
- Highest Sensitivity Due to Automatic Sensitivity Adaption (AGC) and Automatic Strong Signal Adaption (ATC)
- Automatic Supply Voltage Adaptation
- Highest Immunity against Disturbances from Daylight and Lamps
- Available for Carrier Frequencies between 30 kHz to 76 kHz; adjusted by Zener-Diode Fusing ±2.5%
- TTL and CMOS Compatible

Applications

- Home Entertainment Applications (Audio/Video)
- Home Appliances
- Remote Control Equipment

1. Description

The IC T2526 is a complete IR receiver for data communication developed and optimized for use in carrier-frequency-modulated transmission applications. The IC offers highest sensitivity as well as highest suppression of noise from daylight and lamps. The T2526 is available with broadest range of frequencies (30, 33, 36, 37, 38, 40, 44, 56, 76 kHz) and 5 different noise suppression regulation types (standard, lamp, noise, short burst, data rate) covering requirements of high-end remote control solutions (please refer to selection guide available for T2525/T2526). The T2526 operates in a supply voltage range of 2.7V to 5.5V.

The function of the T2526 can be described using the block diagram of Figure 1-1 on page 2. The input stage meets two main functions. First it provides a suitable bias voltage for the PIN diode. Secondly the pulsed photo-current signals are transformed into a voltage by a special circuit which is optimized for low noise applications. After amplification by a Controlled Gain Amplifier (CGA) the signals have to pass a tuned integrated narrow bandpass filter with a center frequency f_0 which is equivalent to the chosen carrier frequency of the input signal The demodulator is used first to convert the input burst signal to a digital envelope output pulse and to evaluate the signal information quality, i.e., unwanted pulses will be suppressed at the output pin. All this is done by means of an integrated dynamic feedback circuit which varies the gain as a function of the present environmental conditions (ambient light, modulated lamps etc.). Other special features are used to adapt to the current application to secure best transmission quality.



Low-voltage IR Receiver ASSP

T2526

4597G-AUTO-10/06





Figure 1-1. Block Diagram



2. Pin Configuration

Figure 2-1. Pinning TSSOP8

	-				
VS	Ц	1	8		NC
NC	Ц	2	7	Þ	NC
OUT	Ц	3	6	þ	GND
NC	Ц	4	5	Þ	IN
	_ L				

Table 2-1.Pin Description

Pin	Symbol	Function
1	VS	Supply voltage
2	NC	Not connected
3	OUT	Data output
4	NC	Not connected
5	IN	Input PIN-diode
6	GND	Ground
7	NC	Not connected
8	NC	Not connected

3. Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameter	Symbol	Value	Unit
Supply voltage	Vs	-0.3 to +6	V
Supply current	۱ _s	3	mA
Input voltage	V _{IN}	–0.3 to V _S	V
Input DC current at $V_S = 5V$	I _{IN}	0.75	mA
Output voltage	Vo	–0.3 to V _S	V
Output current	Ι _Ο	10	mA
Operating temperature	T _{amb}	-25 to +85	°C
Storage temperature	T _{stg}	-40 to +125	C°
Power dissipation at $T_{amb} = 25^{\circ}C$	P _{tot}	30	mW

4. Thermal Resistance

Parameters	Symbol	Value	Unit
Junction ambient TSSOP8	R _{thJA}	TBD	K/W





5. Electrical Characteristics, 3-V Operation

 $T_{amb} = 25^{\circ}C$, $V_{S} = 3V$ unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
1	Supply								
1.1	Supply-voltage range		1	Vs	2.7	3.0	3.3	V	С
1.2	Supply current	I _{IN} =0	1	۱ _s	0.7	0.9	1.3	mA	В
2	Output								
2.1	Internal pull-up resistor ⁽¹⁾	$T_{amb} = 25^{\circ}C$ See Figure 7-10 on page 10	1, 3	R _{PU}		30/40		kΩ	А
2.2	Output voltage low	$R_2 = 2.4 k\Omega$ See Figure 7-10 on page 10	3, 6	V _{OL}			250	mV	В
2.3	Output voltage high		3, 1	V _{OH}	$V_{S} - 0.25$		Vs	V	В
2.4	Output current clamping	R ₂ = 0 See Figure 7-10 on page 10	3, 6	I _{OCL}		8		mA	В
3	Input				•			•	•
3.1	Input DC current	V _{IN} = 0 See Figure 7-10 on page 10	5	I _{IN_DCMAX}	-150			μA	С
3.2	Input DC current See Figure 7-3 on page 7	$V_{IN} = 0$; $Vs = 3V$ $T_{amb} = 25^{\circ}C$	5	I _{IN_DCMAX}		-350		μA	В
3.3	Minimum detection threshold current See Figure 7-1 on page 7	Test signal: See Figure 7-9 on page 10 V _S = 3V	3	I _{Eemin}		-700		рА	В
3.4	Minimum detection threshold current with AC current disturbance IIN_AC100 = 3 µA at 100 Hz	$T_{amb} = 25^{\circ}C, I_{IN_DC} = 1 \mu A$ square pp burst N = 16 f = f ₀ ; t _{PER} = 10 ms Figure 7-8 on page 9 BER = 50 ⁽²⁾	3	I _{Eemin}		-1300		рА	С
3.5	Maximum detection threshold current with V _{IN} > 0V	Test signal: See Figure 7-9 on page 10 $V_S = 3V$, $T_{amb} = 25^{\circ}C$ $I_{IN_DC} = 1 \mu A$ square pp burst N = 16 $f = f_0$; $t_{PER} = 10 \text{ ms}$ Figure 7-8 on page 9 BER = 5% ⁽²⁾	3	l _{Eemax}	-200			μΑ	D

*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Notes: 1. Depending on version, see "Ordering Information"

2. BER = bit error rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT

3. After transformation of input current into voltage

5. Electrical Characteristics, 3-V Operation (Continued)

 $T_{amb} = 25^{\circ}C$, $V_{S} = 3V$ unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
4	Controlled Amplifier and	l Filter							
4.1	Maximum value of variable gain (CGA)			G _{VARMAX}		51		dB	D
4.2	Minimum value of variable gain (CGA)			G _{VARMIN}		-5		dB	D
4.3	Total internal amplification ⁽³⁾			G _{MAX}		71		dB	D
4.4	Center frequency fusing accuracy of bandpass	$V_{\rm S}$ = 3V, $T_{\rm amb}$ = 25°C		f _{03V_FUSE}	-2.5	f ₀	+2.5	%	A
4.5	Overall accuracy center frequency of bandpass			f _{03V}	-5.5	f _o	+3.5	%	С
4.6	Overall accuracy center frequency of bandpass	$T_{amb} = 0$ to $70^{\circ}C$		f _{03V}	-4.5	f ₀	+3.0	%	С
4.7	BPF bandwidth	-3 dB; f ₀ = 38 kHz; See Figure 7-7 on page 9		В		3.8		kHz	С

*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Notes: 1. Depending on version, see "Ordering Information"

- 2. BER = bit error rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT
- 3. After transformation of input current into voltage

6. Electrical Characteristics, 5-V Operation

 $T_{amb} = 25^{\circ}C$, $V_{S} = 5V$ unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
5	Supply								
5.1	Supply-voltage range		1	Vs	4.5	5.0	5.5	V	С
5.2	Supply current	I _{IN} =0	1	۱ _S	0.9	1.2	1.6	mA	В
6	Output								
6.1	Internal pull-up resistor ⁽¹⁾	T _{amb} = 25°C See Figure 7-10 on page 10	1, 3	R _{PU}		30/40		kΩ	А
6.2	Output voltage low	$R_2 = 2.4 \text{ k}\Omega$ See Figure 7-10 on page 10	3, 6	V _{OL}			250	mV	В
6.3	Output voltage high		3, 1	V _{OH}	$V_{S} - 0.25$		Vs	V	В
6.4	Output current clamping	R ₂ = 0 See Figure 7-10 on page 10	3, 6	I _{OCL}		8		mA	В

*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Notes: 1. Depending on version, see "Ordering Information"

2. BER = bit error rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT

3. After transformation of input current into voltage





6. Electrical Characteristics, 5-V Operation (Continued)

 $T_{amb} = 25^{\circ}C$, $V_{S} = 5V$ unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
7	Input								
7.1	Input DC current	$V_{IN} = 0$ See Figure 7-10 on page 10	5	I _{IN_DCMAX}	-400			μA	С
7.2	Input DC-current See Figure 7-4 on page 8	$V_{IN} = 0; Vs = 5V$ $T_{amb} = 25^{\circ}C$	5	I _{IN_DCMAX}		-700		μΑ	В
7.3	Min. detection threshold current See Figure 7-2 on page 7	Test signal: See Figure 7-9 on page 10 $V_S = 5V$ $T_{amb} = 25^{\circ}C$	3	I _{Eemin}		-850		pА	В
7.4	Min. detection threshold current with AC current disturbance IIN_AC100 = 3 µA at 100 Hz	$I_{\text{IN}_DC} = 1 \ \mu\text{A}$ square pp burst N = 16 f = f ₀ ; t _{PER} = 10 ms Figure 7-8 on page 9 BER = 50 ⁽²⁾	3	I _{Eemin}		-2000		рА	С
7.5	Max. detection threshold current with V _{IN} > 0V	Test signal: See Figure 7-9 on page 10 $V_S = 5V$, $T_{amb} = 25^{\circ} C I_{IN_DC} =$ 1 μA square pp burst N = 16 $f = f_0$; $t_{PER} = 10$ ms Figure 7-8 on page 9 BER = 5% ⁽²⁾	3	I _{Eemax}	-500			μΑ	D
8	Controlled Amplifier a	nd Filter		1	1		1	1	
8.1	Maximum value of variable gain (CGA)			G _{VARMAX}		51		dB	D
8.2	Minimum value of variable gain (CGA)			G _{VARMIN}		-5		dB	D
8.3	Total internal amplification ⁽³⁾			G _{MAX}		71		dB	D
8.4	Resulting center frequency fusing accuracy	f_0 fused at V _S = 3V V _S = 5V, T _{amb} = 25°C		f _{05V}		f _{03V-FUSE} + 0.5		%	А

*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Notes: 1. Depending on version, see "Ordering Information"

2. BER = bit error rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT

3. After transformation of input current into voltage

6.1 ESD

All pins ⇒2000V HBM; 200V MM, MIL-STD-883C, Method 3015.7

6.2 Reliability

Electrical qualification (1000h) in molded plastic package

Typical Electrical Curves at T_{amb} = 25°C 7.

Figure 7-1.



Figure 7-2. I_{Eemin} versus $I_{\text{IN}_{\text{DC}}}$, $V_{\text{S}} = 5V$



Figure 7-3. V_{IN} versus $I_{IN_{DC}}$, $V_{S} = 3V$







Figure 7-4. V_{IN} versus I_{IN_DC} , $V_S = 5V$

0.1





0 +



1

100

1000

10

 I_{IN_DC} (µA)

Figure 7-6. Data Transmission Rate, $V_s = 5V$



T2526

Figure 7-7. Typical Bandpass Curve

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 $Q = f/f_0/B$; B => -3 dB values.

Example:
$$Q = 1/(1.047 - 0.954) = 11$$







Figure 7-9. Test Circuit







Chip Dimensions 8.



Pad coordinates are given for lower left corner of the pad in μm from the origin 0,0 Note:

Dimensions	Length inclusive scribe	1.16 mm
	Width inclusive scribe	1.37 mm
	Thickness	$290~\mu\pm5\%$
	Pads	90 $\mu \times$ 90 μ
	Fusing pads	70 $\mu \times$ 70 μ
Pad metallurgy	Material	AlCu/AlSiTi ⁽¹⁾
	Thickness	0.8 µm
Finish	Material	Si_3N_4/SiO_2
	Thickness	0.7/0.3 µm

Note: 1. Value depends on manufacture location.





9. Ordering Information

Delivery: unsawn wafers (DDW) in box

Extended Type Number	PL ⁽²⁾	R _{PU} ⁽³⁾	D ⁽⁴⁾	Type ⁽⁵⁾	
T2526N0xx ⁽¹⁾ -DDW	2	30	2179	Standard type: > 10 pulses, enhanced cancibility bigh data rate	
T2526N1xx ⁽¹⁾ -DDW	1	30	2179	Standard type: 2 10 pulses, enhanced sensibility, high data rate	
T2526N2xx ⁽¹⁾ -DDW	2	40	1404	Lamp type: \geq 10 pulses, enhanced suppression of disturbances, secure	
T2526N3xx ⁽¹⁾ -DDW	1	40	1404	data transmission	
T2526N6xx ⁽¹⁾ -DDW	2	30	3415		
T2526N7xx ⁽¹⁾ -DDW	1	30	3415	Short burst type: ≥ 6 pulses, enhanced data rate	

Notes: 1. xx means the used carrier frequency value f₀ 30, 33, 36, 38, 40, 44 or 56 kHz (76 kHz type on request)

- 2. Two pad layout versions (see Figure 9-1 and Figure 9-2) available for different assembly demand
- 3. Integrated pull-up resistor at pin OUT (see electrical characteristics)
- 4. Typical data transmission rate up to bit/s with $f_0 = 56$ kHz, $V_S = 5$ V (see Figure 7-8 on page 9)
- 5. On request: noise type, data rate type

9.1 Pad Layout





Figure 9-2. Pad Layout 2

(6)	(5) [] IN
(1) VS	
	T2526
(3)	Fusing

10. Revision History www.DataSheet4U.com

Please note that the following page numbers referred to in this section refer to the specific revision mentioned, not to this document.

Revision No.	History				
	Features on page 1 changed				
	 Applications on page 1 changed 				
	 Section 1 "Description" on page 1 changed 				
4597G-AUTO-10/06	 Section 5 "Electrical Characteristics, 3-V Operation" number 3.4 on page 3 changed 				
	 Section 6 "Electrical Characteristics, 5-V Operation" number 7.3 and 7.4 on page 5 changed 				
	 Section 9 "Ordering Information" on page 11 changed 				
4597F-AUTO-04/06	 Section 9 "Ordering Information" on page 11 changed 				
	 Put datasheet in a new template 				
4597E-AUTO-04/00	 Section 8 "Chip Dimensions" on page 10 changed 				
	Put datasheet in a new template				
	First page: Pb-free logo added				
	Page 11: Ordering Information changed				
	• Page 2, 3, 5, 11, 13: SO8 deleted				





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